

Search Notes

Application/Control No.

09/886,741

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E25.023, 723, 724, 796 & 787	11/7/2006	C.C.
257	784 & 685	11/7/2006	C.C.
257	780 & 778	11/7/2006	C.C.
257	731 & 706	11/7/2006	C.C.
257	668 & 698	11/7/2006	C.C.
257	700 & 707	11/7/2006	C.C.
438	106 & 107	11/7/2006	C.C.
361	767	11/7/2006	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
As same	as above	11/7/2006	C.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; FPRS; and IBM_TDB;	11/7/2006	C.C.